## Notice of References Cited Application/Control No. 10/750,847 Examiner Tuyet Vo Applicant(s)/Patent Under Reexamination LEE ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,433,321	08-2002	Lee et al.	219/715
*	В	US-6,222,746	04-2001	Kim, Hong-Ki	363/89
*	С	US-6,335,520	01-2002	Lee et al.	219/716
*	D	US-5,371,440	12-1994	Liu et al.	315/209R
*	E	US-5,250,775	10-1993	Maehara et al.	219/771
*	F	US-4,593,167	06-1986	Nilssen, Ole K.	219/715
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-		·	
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification		
	N	WO 98/11655	03-1998	SWEDEN				
	0							
	Р							
	a							
	R							
	S							
	Т							

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	V	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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